## Application/Control No. Applicant(s)/Patent Under Reexamination 09/701,653 BANCTEL ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Haresh Patel 2154 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 715/835 US-6,078,324 06-2000 Phathayakorn et al. Α US-4,868,743 09-1989 Nishio, Takanori 707/3 В 707/103X С US-6,317,748 11-2001 Menzies et al. 11-1998 Pettus, Christopher E. 709/203 D US-5,832,219 05-2002 709/226 US-6,385,650 Skog et al. Ε F US-6,115,646 09-2000 Fiszman et al. 700/181 US-2003/0088708 05-2003 LEWALLEN, STEPHEN 709/315 G US-6,438,594 08-2002 Bowman-Amuah, Michel K. 709/225 Н ı US-6,687,761 02-2004 Collins et al. 719/315 11-2004 707/9 US-6,823,338 Byrne et al. 04-2001 Pettus, Christopher E. 709/219 US-6,223,217 Κ 09-2002 707/3 US-6,453,312 Goiffon et al. L US-6,189,103 02-2001 Nevarez et al. 713/201 М **FOREIGN PATENT DOCUMENTS** Date **Document Number** Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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